Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO. 240060US3		SERIAL NO. New Application			
(Modified)		PATENT AND TRA	DEMARK OFFICE						
				APPLICANT					
LIST OF REFERENCES CITED BY APPLICANT			Ryoji HABUCHI, et al.						
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FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO		LATION NO	
760	AO	2002-327828	11/15/02	Japan (with English Abstract)	-	×		Х	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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	AZ		 		Additional References sheet(s) attached				
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*Examiner: Initial if reference is considered, with a conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									